

KLA TENCOR 2835 Patterned Defect Inspection System Introduction

General

The new 2835 Series bright field inspection platform introduces Power Broadband, a unique high-brightness light source designed to enable more repeatable capture of difficult defects, faster operation, and better discrimination between defects of interest and nuisance defects. Also equipped with a new image acquisition system featuring twice the data rate of its 2810 Series predecessor, the 2835 Series offers its markedly increased capability at production speeds

Configuration

No.	Description	Component
1	User Interface	Monitor
		Workstation

		Keyboard / Trackball / Joystick	
		etc.	
2	Main Unit	Inspection station	
		X-Y stage	
		Optic system	
		etc.	
3	Handler	Robot	
		Pre-aligner	
		Arm	
		etc.	
4	Aux Racket	1 set	
5	External Blower	1 set	
6	Power Line Conditioner	1 set	

Specification

General				
Wafer size	200/300mm(8/12inch)			
Wavelength illumination	260~450nm			
Wavelength band	Visible, UV, DUV			
Pixel Size	0.08μm / 0.09μm / 0.12μm / 0.16μm / 0.20μm / 0.23μm			
Small Pixel Size	0.050μm / 0.065μm			
Capture Rate	≥90% for production worthy recipes			
Defect Rate	<1.5%	<1.5% for production worthy re		
Repeatability	95% for production worthy recipes			
	Pixel Size	Scan Rate (sec/cm2)		
C D	(um)	Array	Random	
Scan Rate	0.16	1.05	1.11	
	0.20	0.76	0.82	
Die Size	1.5mm to 40mm on a side			
Edge Exclusion	3mm			

Care Area	X=1.5um,Y=1.5um
Border Limits	

Working condition

Item	Specification	
Electric Power	208 VAC, 3 phase WYE power, 50/60Hz, 30kVA,	
Vocassa	Min 25inHg(84.6kPa)	
Vacuum	3/8 inch OD tube	
CDA	100 PSIG (689kPa)	
CDA	3/8 inch electropolished stainless steel tube	
N2	30~80PSI (206-552kPa)	
11/2	1/4 inch electropolished stainless steel tube	
Temperature	20~25°C, Stability: ±1°C	
Humidity	30%~60%	
Cleanroom class	Class 100 or better	
Vilonation	Less than 12.8 μm/sec RMS,	
Vibration	between 0.1 Hz - 1000 Hz	